SHEET 1 OF 1 INFORMATION DISCLOSURE SERIAL NO. ATTY. DOCKET NO. 10473-635 09/892,906 CITATION IN AN APPLICATION **APPLICANT David A. JACKSON GROUP FILING DATE** (PTO-1449) June 28, 2001 2859 PATENT DOCUMENTS FILING DATE **EXAMINER'S INITIALS NAME CLASS SUBCLASS** PATENT NO. DATE 356 12/28/95 139.09 3/3/98 5,724,128 January -J-CC 3/4/85 4,643,578 376 2/17/87 Stern 356 TU FOREIGN PATENT DOCUMENTS **EXAMINER'S** Translation **COUNTRY SUBCLASS INITIALS CLASS** PATENT NO. DATE Yes No Great Britain 4/26/95 GB 2283 090 A ACC FR 2735861 A 6/23/95 France JEC OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) TANIA C. COURSON **EXAMINER DATE CONSIDERED**

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

9/24/62

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4CC	5,535,522	July 16, 1996	Jackson					•			
4CC	5,724,743	March 10, 1998	Jackson					, '			
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TLL	WO 98/48241	10/29/1998	International				X			
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